

# SN54AHCT541, SN74AHCT541 OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

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- Inputs Are TTL-Voltage Compatible
- **EPIC™** (Enhanced-Performance Implanted CMOS) Process
- High Latch-Up Immunity Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

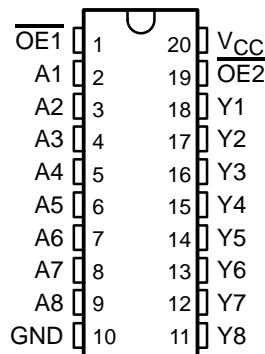
## description

The 'AHCT541 octal buffers/drivers are ideal for driving bus lines or buffer memory address registers. These devices feature inputs and outputs on opposite sides of the package to facilitate printed-circuit-board layout.

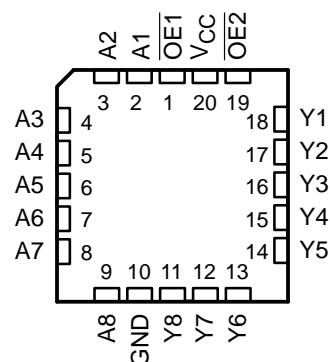
The 3-state control gate is a 2-input AND gate with active-low inputs so that if either output-enable ( $\overline{OE1}$  or  $\overline{OE2}$ ) input is high, all corresponding outputs are in the high-impedance state. The outputs provide noninverted data when they are not in the high-impedance state.

The SN54AHCT541 is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74AHCT541 is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

SN54AHCT541 . . . J OR W PACKAGE  
SN74AHCT541 . . . DB, DGV, DW, N, OR PW PACKAGE  
(TOP VIEW)



SN54AHCT541 . . . FK PACKAGE  
(TOP VIEW)



FUNCTION TABLE

INPUTS			OUTPUT Y
$\overline{OE1}$	$\overline{OE2}$	A	
L	L	L	L
L	L	H	H
H	X	X	Z
X	H	X	Z



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## recommended operating conditions (see Note 3)

		SN54AHCT541		SN74AHCT541		UNIT
		MIN	MAX	MIN	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5.5	4.5	5.5	V
V <sub>IH</sub>	High-level input voltage	2		2		V
V <sub>IL</sub>	Low-level input voltage		0.8		0.8	V
V <sub>I</sub>	Input voltage	0	5.5	0	5.5	V
V <sub>O</sub>	Output voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current		–8		–8	mA
I <sub>OL</sub>	Low-level output current		8		8	mA
Δt/Δv	Input transition rise or fall rate		20		20	ns/V
T <sub>A</sub>	Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	T <sub>A</sub> = 25°C			SN54AHCT541		SN74AHCT541		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V <sub>OH</sub>	I <sub>OH</sub> = –50 μA	4.5 V	4.4	4.5		4.4		4.4		V
	I <sub>OH</sub> = –8 mA		3.94			3.8		3.8		
V <sub>OL</sub>	I <sub>OL</sub> = 50 μA	4.5 V			0.1		0.1		0.1	V
	I <sub>OL</sub> = 8 mA				0.36		0.44		0.44	
I <sub>OZ</sub>	V <sub>O</sub> = V <sub>CC</sub> or GND	5.5 V			±0.25		±2.5		±2.5	μA
I <sub>I</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5.5 V			±0.1		±1		±1	μA
I <sub>CC</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND, I <sub>O</sub> = 0	5.5 V			4		40		40	μA
ΔI <sub>CC</sub> <sup>†</sup>	One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND	5.5 V			1.35		1.5		1.5	mA
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		2	10				10	pF
C <sub>o</sub>	V <sub>O</sub> = V <sub>CC</sub> or GND	5 V		4						pF

<sup>†</sup> This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

# SN54AHCT541, SN74AHCT541

## OCTAL BUFFERS/DRIVERS

### WITH 3-STATE OUTPUTS

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switching characteristics over recommended operating free-air temperature range,  
 $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	SN54AHCT541				UNIT
				$T_A = 25^\circ\text{C}$			MIN	MAX
				MIN	TYP	MAX		
$t_{PLH}^*$	A	Y	$C_L = 15\text{ pF}$	4.1	6	1	6.5	ns
$t_{PHL}^*$				3.7	5.5	1	6.5	
$t_{PZH}^*$	$\overline{OE}$	Y	$C_L = 15\text{ pF}$	5	7	1	8	ns
$t_{PZL}^*$				5	7	1	8	
$t_{PHZ}^*$	$\overline{OE}$	Y	$C_L = 15\text{ pF}$	4.5	7	1	8	ns
$t_{PLZ}^*$				4.5	7	1	8	
$t_{PLH}$	A	Y	$C_L = 50\text{ pF}$	6.2	8.5	1	9.5	ns
$t_{PHL}$				6	8.5	1	9.5	
$t_{PZH}$	$\overline{OE}$	Y	$C_L = 50\text{ pF}$	7.5	10	1	12	ns
$t_{PZL}$				7.5	10	1	12	
$t_{PHZ}$	$\overline{OE}$	Y	$C_L = 50\text{ pF}$	7	10	1	12	ns
$t_{PLZ}$				7	10	1	12	

\* On products compliant to MIL-PRF-38535, this parameter is ensured but not production tested.

switching characteristics over recommended operating free-air temperature range,  
 $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	SN74AHCT541				UNIT
				$T_A = 25^\circ\text{C}$			MIN	MAX
				MIN	TYP	MAX		
$t_{PLH}$	A	Y	$C_L = 15\text{ pF}$	4.1	6	1	6.5	ns
$t_{PHL}$				3.7	5.5	1	6.5	
$t_{PZH}$	$\overline{OE}$	Y	$C_L = 15\text{ pF}$	5	7	1	8	ns
$t_{PZL}$				5	7	1	8	
$t_{PHZ}$	$\overline{OE}$	Y	$C_L = 15\text{ pF}$	4.5	7	1	8	ns
$t_{PLZ}$				4.5	7	1	8	
$t_{PLH}$	A	Y	$C_L = 50\text{ pF}$	6.2	8.5	1	9.5	ns
$t_{PHL}$				6	8.5	1	9.5	
$t_{PZH}$	$\overline{OE}$	Y	$C_L = 50\text{ pF}$	7.5	10	1	12	ns
$t_{PZL}$				7.5	10	1	12	
$t_{PHZ}$	$\overline{OE}$	Y	$C_L = 50\text{ pF}$	7	10	1	12	ns
$t_{PLZ}$				7	10	1	12	

output-skew characteristics,  $C_L = 50\text{ pF}$  (see Note 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub>	SN74AHCT541				UNIT
				T <sub>A</sub> = 25°C		MIN	MAX	
				MIN	MAX			
t <sub>sk(o)</sub>	A	Y	5 V ± 0.5 V	1		1	ns	

NOTE 4: Characteristics are determined during product characterization and ensured by design.

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noise characteristics,  $V_{CC} = 5\text{ V}$ ,  $C_L = 50\text{ pF}$ ,  $T_A = 25^\circ\text{C}$  (see Note 5)

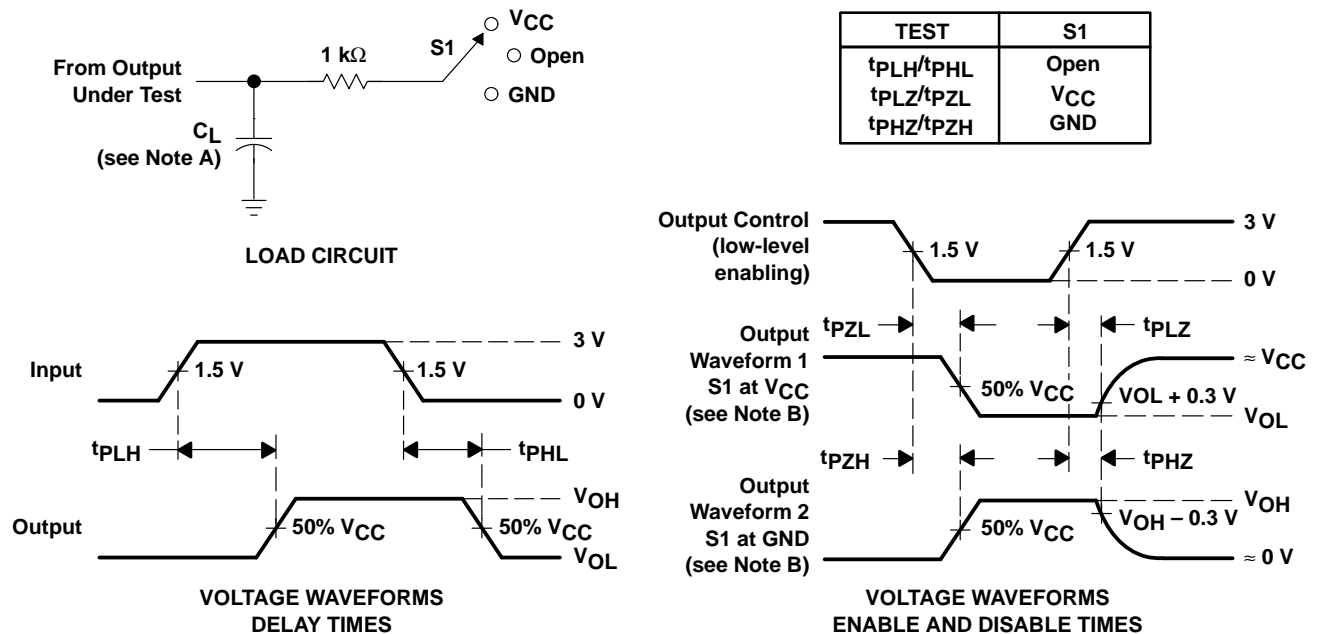
PARAMETER	SN74AHCT541		UNIT
	MIN	MAX	
$V_{IH(D)}$ High-level dynamic input voltage	2		V
$V_{IL(D)}$ Low-level dynamic input voltage		0.8	V

NOTE 5: Characteristics are determined during product characterization and ensured by design for surface-mount packages only.

operating characteristics,  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
$C_{pd}$ Power dissipation capacitance	No load, $f = 1\text{ MHz}$	12	pF

## PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.

Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 1\text{ MHz}$ ,  $Z_O = 50\ \Omega$ ,  $t_r = 3\text{ ns}$ ,  $t_f = 3\text{ ns}$ .

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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